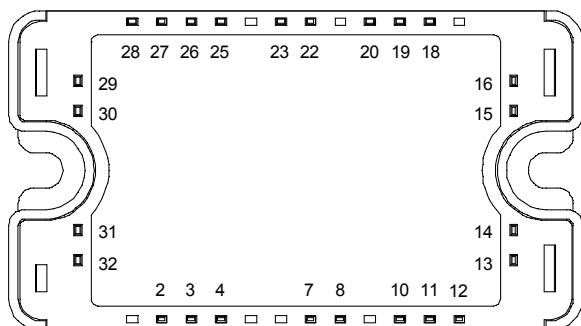
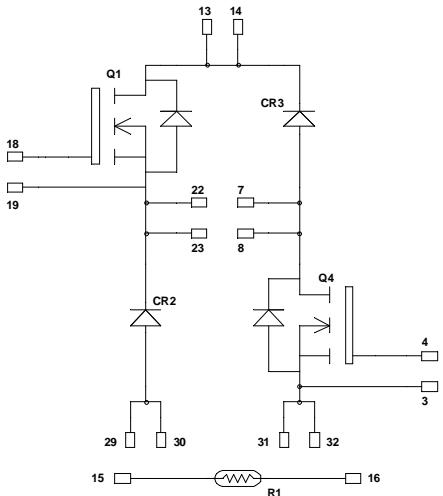


**Asymmetrical - Bridge
MOSFET Power Module**

V_{DSS} = 200V
R_{DSon} = 20mΩ typ @ T_j = 25°C
I_D = 89A @ T_c = 25°C



All multiple inputs and outputs must be shorted together
 Example: 13/14 ; 29/30 ; 22/23 ...

Absolute maximum ratings

Symbol	Parameter	Max ratings	Unit
V _{DSS}	Drain - Source Breakdown Voltage	200	V
I _D	Continuous Drain Current	T _c = 25°C T _c = 80°C	89 66
I _{DM}	Pulsed Drain current		
V _{GS}	Gate - Source Voltage	±30	V
R _{DSon}	Drain - Source ON Resistance	24	mΩ
P _D	Maximum Power Dissipation	T _c = 25°C	357
I _{AR}	Avalanche current (repetitive and non repetitive)		
E _{AR}	Repetitive Avalanche Energy	89	A
E _{AS}	Single Pulse Avalanche Energy	50	mJ
		2500	

 **CAUTION:** These Devices are sensitive to Electrostatic Discharge. Proper Handling Procedures Should Be Followed. See application note APT0502 on www.microsemi.com

All ratings @ $T_j = 25^\circ\text{C}$ unless otherwise specified

Electrical Characteristics

Symbol	Characteristic	Test Conditions		Min	Typ	Max	Unit
I_{DSS}	Zero Gate Voltage Drain Current	$V_{GS} = 0\text{V}$, $V_{DS} = 200\text{V}$	$T_j = 25^\circ\text{C}$			100	μA
		$V_{GS} = 0\text{V}$, $V_{DS} = 160\text{V}$	$T_j = 125^\circ\text{C}$			500	
$R_{DS(on)}$	Drain – Source on Resistance	$V_{GS} = 10\text{V}$, $I_D = 44.5\text{A}$			20	24	$\text{m}\Omega$
$V_{GS(\text{th})}$	Gate Threshold Voltage	$V_{GS} = V_{DS}$, $I_D = 2.5\text{mA}$		3		5	V
I_{GSS}	Gate – Source Leakage Current	$V_{GS} = \pm 30\text{ V}$, $V_{DS} = 0\text{V}$				± 100	nA

Dynamic Characteristics

Symbol	Characteristic	Test Conditions		Min	Typ	Max	Unit
C_{iss}	Input Capacitance	$V_{GS} = 0\text{V}$	$V_{DS} = 25\text{V}$		6850		pF
C_{oss}	Output Capacitance				2180		
C_{rss}	Reverse Transfer Capacitance		$f = 1\text{MHz}$		97		
Q_g	Total gate Charge	$V_{GS} = 10\text{V}$			112		nC
Q_{gs}	Gate – Source Charge		$V_{Bus} = 100\text{V}$		43		
Q_{gd}	Gate – Drain Charge		$I_D = 75\text{A}$		47		
$T_{d(on)}$	Turn-on Delay Time		Inductive switching @ 125°C		28		ns
T_r	Rise Time	$V_{GS} = 15\text{V}$			56		
$T_{d(off)}$	Turn-off Delay Time	$V_{Bus} = 133\text{V}$			81		
T_f	Fall Time	$I_D = 75\text{A}$			99		
E_{on}	Turn-on Switching Energy	Inductive switching @ 25°C			463		μJ
E_{off}	Turn-off Switching Energy	$V_{GS} = 15\text{V}$, $V_{Bus} = 133\text{V}$			455		
E_{on}	Turn-on Switching Energy	Inductive switching @ 125°C			608		μJ
E_{off}	Turn-off Switching Energy	$V_{GS} = 15\text{V}$, $V_{Bus} = 133\text{V}$			531		

Diode ratings and characteristics

Symbol	Characteristic	Test Conditions		Min	Typ	Max	Unit	
V_{RRM}	Maximum Peak Repetitive Reverse Voltage	$V_R = 200\text{V}$	$T_j = 25^\circ\text{C}$	200			V	
I_{RM}	Maximum Reverse Leakage Current		$T_j = 125^\circ\text{C}$			250	μA	
I_F	DC Forward Current		$T_c = 80^\circ\text{C}$		100		A	
V_F	Diode Forward Voltage	$I_F = 100\text{A}$			1		V	
		$I_F = 200\text{A}$			1.4			
		$I_F = 100\text{A}$	$T_j = 125^\circ\text{C}$		0.9			
t_{rr}	Reverse Recovery Time	$I_F = 100\text{A}$	$T_j = 25^\circ\text{C}$		60		ns	
			$T_j = 125^\circ\text{C}$		110			
Q_{rr}	Reverse Recovery Charge		$T_j = 25^\circ\text{C}$		200		nC	
			$T_j = 125^\circ\text{C}$		840			

Thermal and package characteristics

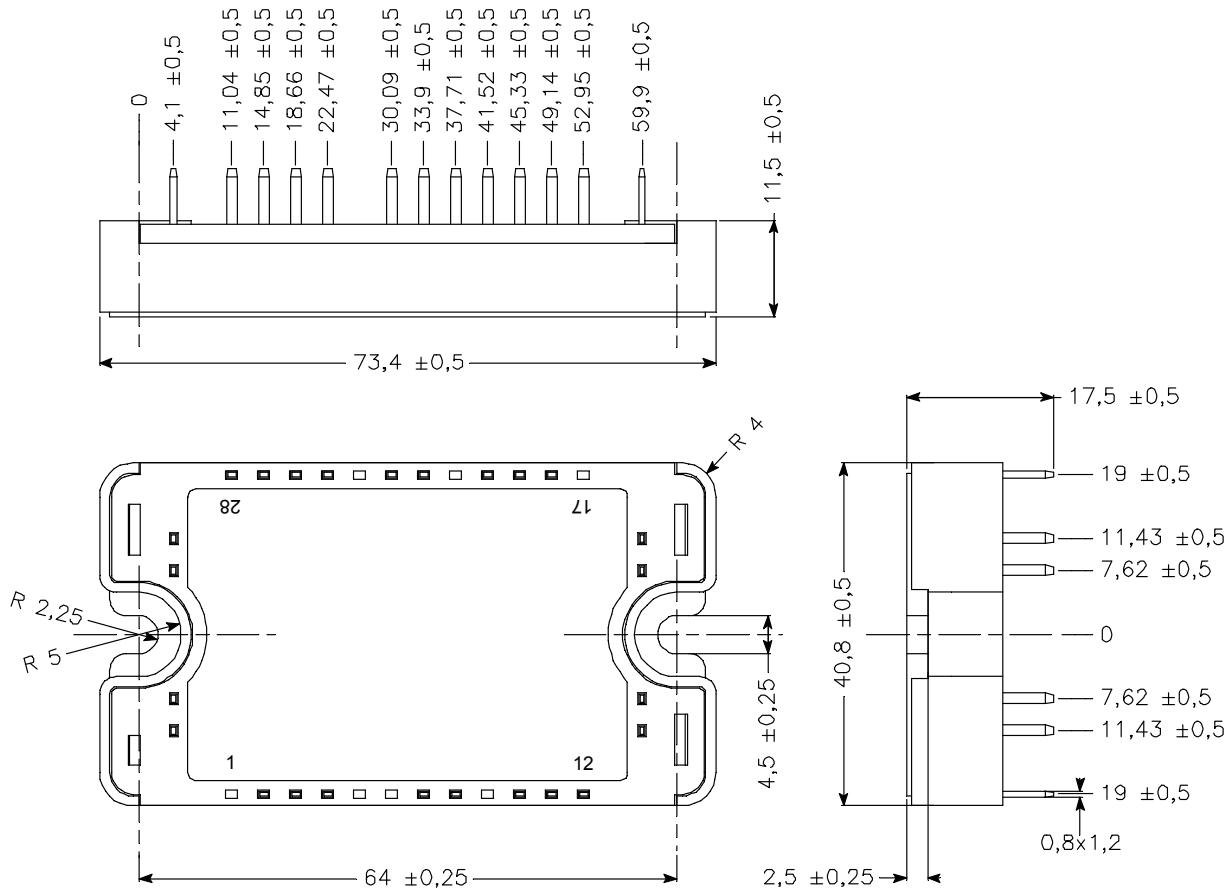
Symbol	Characteristic		Min	Typ	Max	Unit
R_{thJC}	Junction to Case Thermal Resistance	MOSFET			0.35	°C/W
		diode			0.55	
V_{ISOL}	RMS Isolation Voltage, any terminal to case t = 1 min, $I_{isol} < 1mA$, 50/60Hz	4000				V
T_J	Operating junction temperature range	-40		150		
T_{STG}	Storage Temperature Range	-40		125		°C
T_C	Operating Case Temperature	-40		100		
Torque	Mounting torque	To heatsink	M4	2.5	4.7	N.m
Wt	Package Weight				110	g

Temperature sensor NTC (see application note APT0406 on www.microsemi.com for more information).

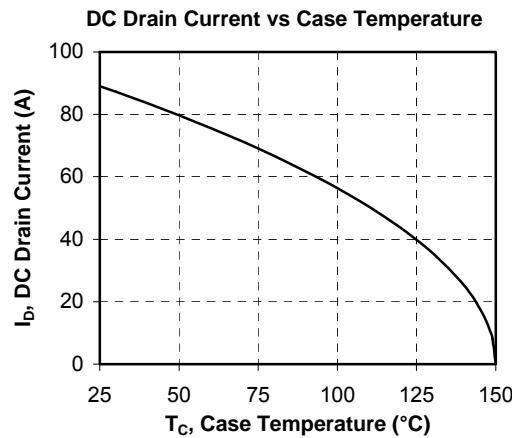
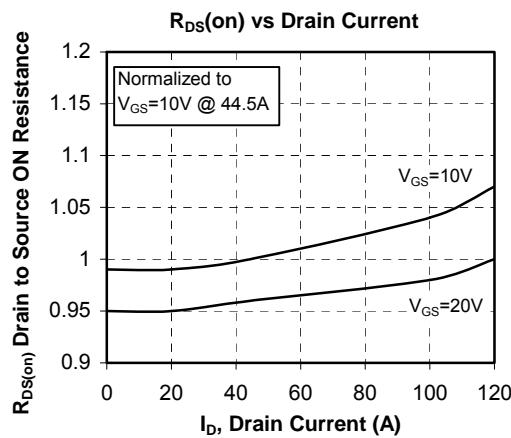
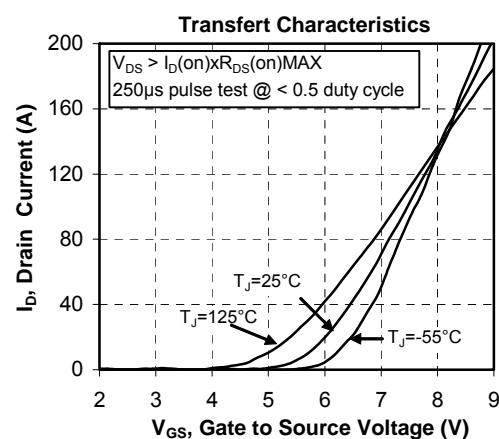
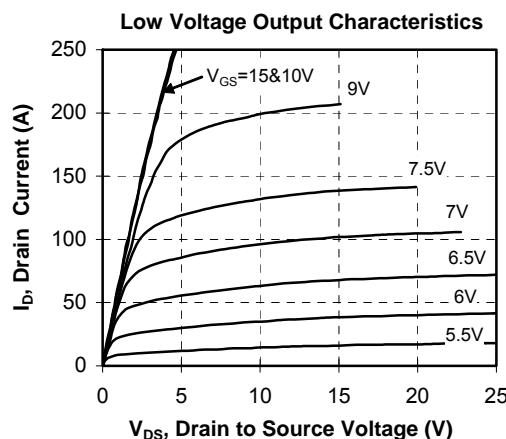
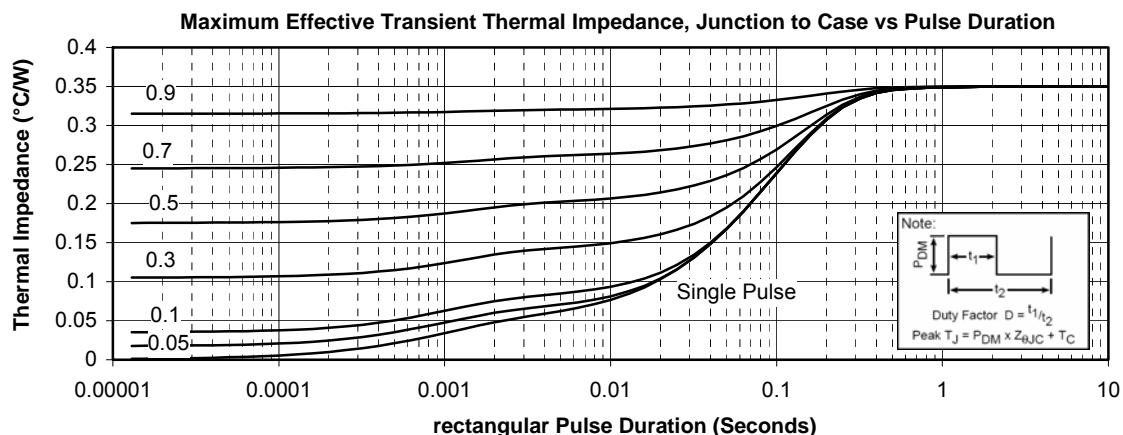
Symbol	Characteristic		Min	Typ	Max	Unit
R_{25}	Resistance @ 25°C			50		kΩ
$\Delta R_{25}/R_{25}$				5		%
$B_{25/85}$	$T_{25} = 298.15 \text{ K}$			3952		K
$\Delta B/B$		$T_C=100^\circ\text{C}$		4		%

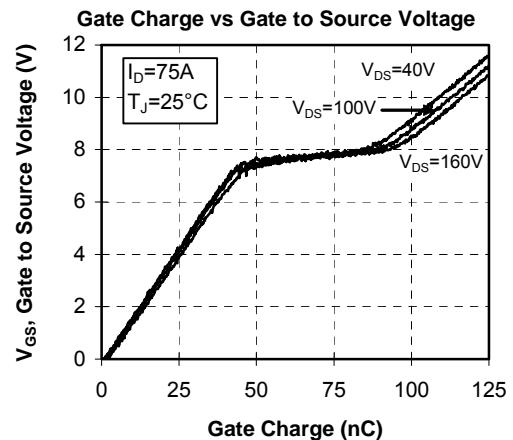
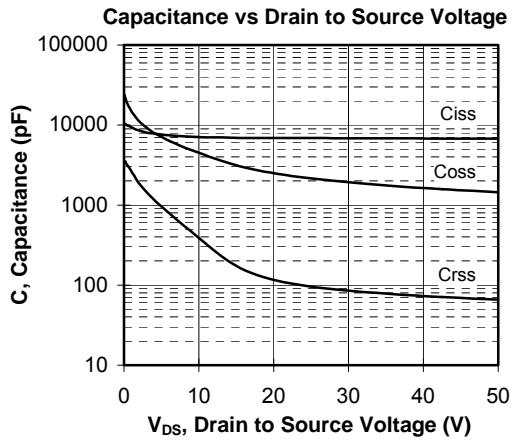
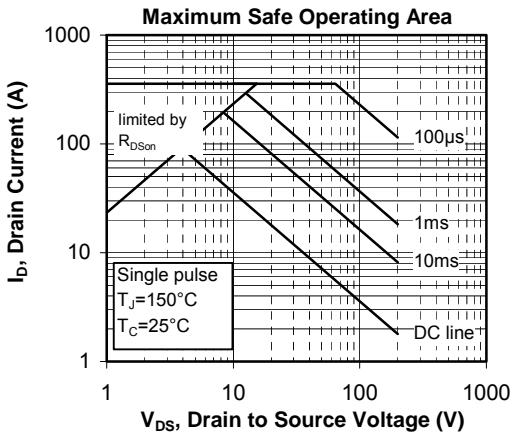
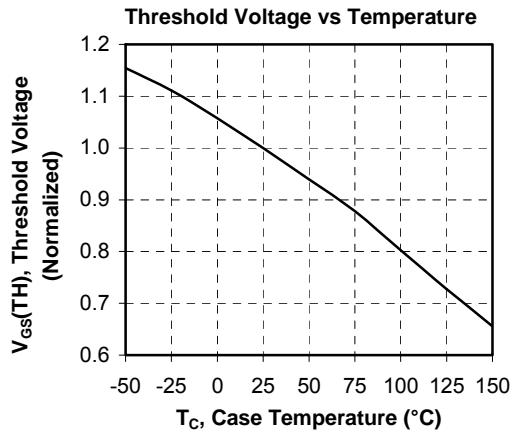
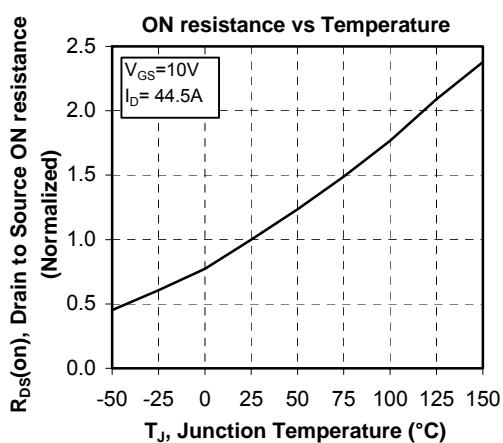
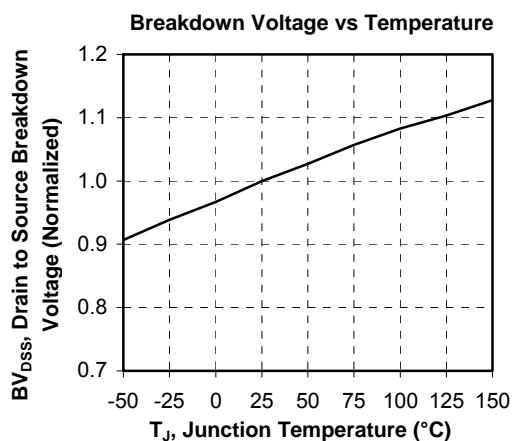
$$R_T = \frac{R_{25}}{\exp\left[B_{25/85}\left(\frac{1}{T_{25}} - \frac{1}{T}\right)\right]}$$

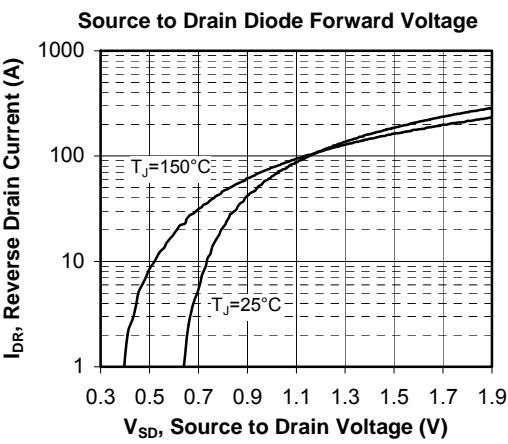
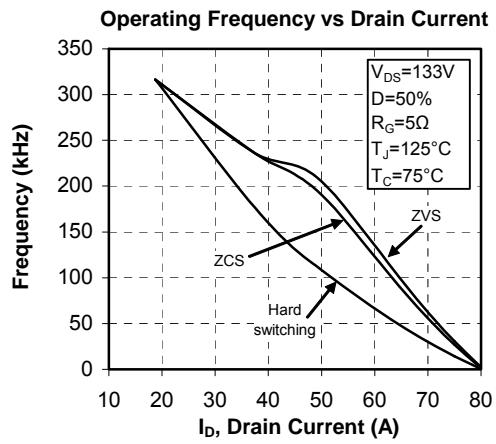
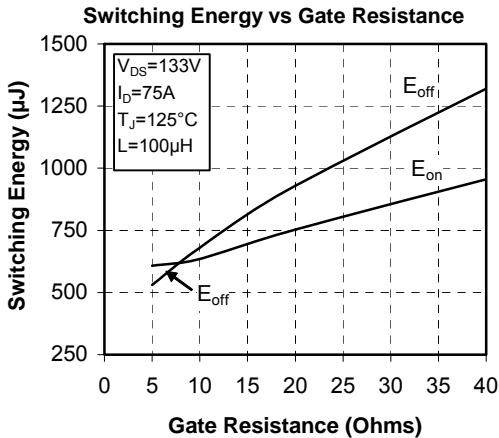
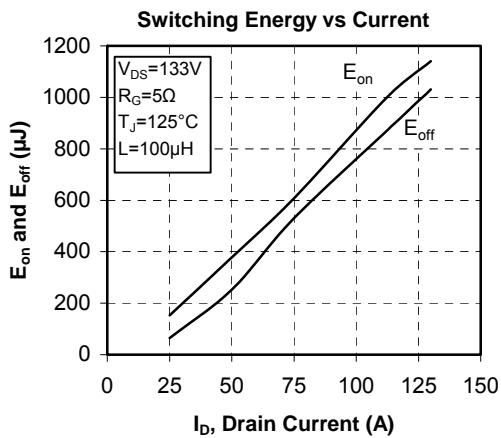
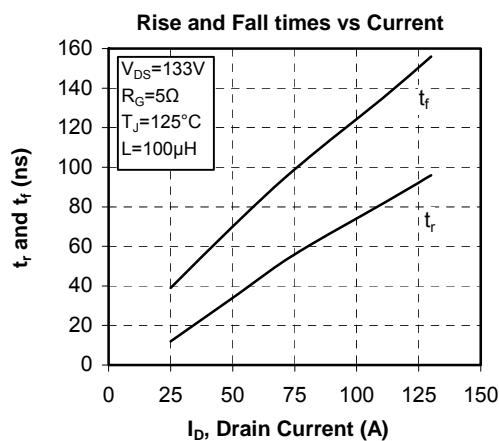
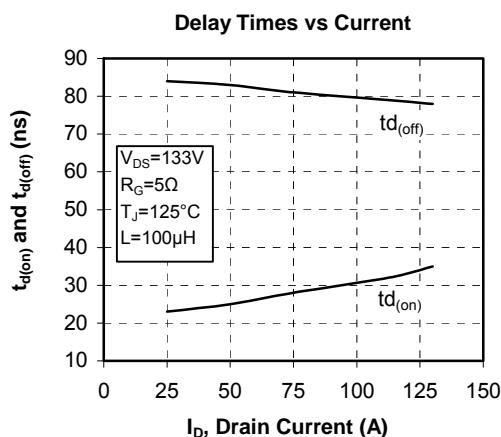
T: Thermistor temperature
R_T: Thermistor value at T

SP3 Package outline (dimensions in mm)

See application note 1901 - Mounting Instructions for SP3 Power Modules on www.microsemi.com

Typical MOSFET Performance Curve

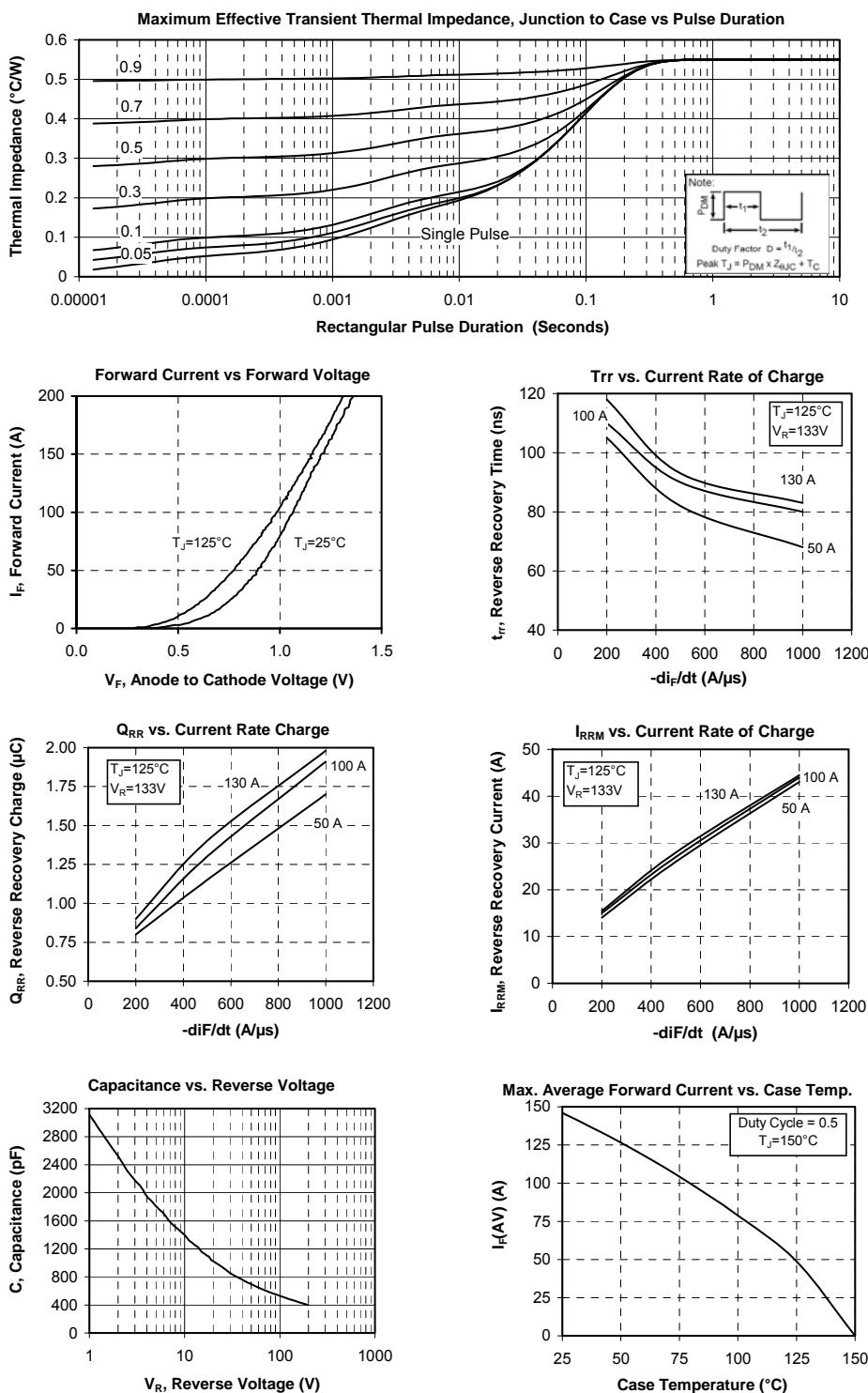








Typical Diode Performance Curve



Microsemi's products are covered by one or more of U.S patents 4,895,810 5,045,903 5,089,434 5,182,234 5,019,522 5,262,336 6,503,786 5,256,583 4,748,103 5,283,202 5,231,474 5,434,095 5,528,058 6,939,743 7,352,045 5,283,201 5,801,417 5,648,283 7,196,634 6,664,594 7,157,886 6,939,743 7,342,262 and foreign patents. U.S and Foreign patents pending. All Rights Reserved.